

Notice of References Cited	Application/Control No. 10/690,425		Applicant(s)/Patent Under Reexamination LIU ET AL.	
	Examiner Michael Barr		Art Unit 1762	Page 1 of 1

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X	A	US-6,250,765	06-2001	Murakami, Tetsuya	359/609
	B	US-6,329,058	12-2001	Arney et al.	428/403
	C	US-			
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	I	US-			
	J	US-			
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	L	US-			
	M	US-			

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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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